

## **Search Notes**



**Application/Control No.**

10/656-199

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**Examiner**

Phat X. Cao

**Applicant(s)/Patent under  
Reexamination**

NAKATA ET AL.

## Art Unit

2814

SEARCHED

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**